

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/040,759	KWON, HYUCK JIN	
	Examiner	Art Unit	
	Khawar Iqbal	2688	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0088637	05-2003	HATANO et al.	709/216
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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